Search Notes

Application/Control I	No. Applicant(s)/Patent u Reexamination	nder
10/008,465	DIAZ, RAYMOND	
Examiner	Art Unit	
Ted M. Wang	2634	

	SEARCHED				
Class	Subclass	Date	Examiner		
375	222	8/26/2005	τw		
375	224	8/26/2005	TW		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	8/26/2005	TW		
IEEE - Advance search -gathering or collecting or measuring) and statistics and time interval	8/26/05	TW		
IEEE - Advance search (chronologcal time clock) or (absolute time clock) and telecommunication and statistics	8/26/2005	TW		
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